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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/004,961	12/03/2001	John D. Holder	MEMC 00-1100 (2808.1)	7824
321 75	590 02/25/2004		EXAMINER	
SENNIGER POWERS LEAVITT AND ROEDEL			ANDERSON, MATTHEW A	
ONE METROF 16TH FLOOR	POLITAN SQUARE		ART UNIT	PAPER NUMBER
ST LOUIS, M	O 63102		1765	
			DATE MAILED: 02/25/2004	1

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Please find below and/or attached an Office communication concerning this application or proceeding.

	Application No.	Applicant(s)	A
e je <sup>™</sup> e i			("
Office Action Summary	10/004,961	HOLDER ET AL.	
	Examiner	Art Unit	
The MAIL INC DATE of this communication on	Matthew A. Anderson	1765	
The MAILING DATE of this communication appearing for Reply	pears on the cover sheet with the t	correspondence address	5
A SHORTENED STATUTORY PERIOD FOR REPL THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.  after SIX (6) MONTHS from the mailing date of this communication.  - If the period for reply specified above is less than thirty (30) days, a rep  - If NO period for reply is specified above, the maximum statutory period  - Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailin earned patent term adjustment. See 37 CFR 1.704(b).	136(a). In no event, however, may a reply be till ly within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from a, cause the application to become ABANDONE	mely filed  ys will be considered timely.  n the mailing date of this commun  ED (35 U.S.C. § 133).	ilcation.
Status			
1) Responsive to communication(s) filed on $05 E$	<u> Pecember 2003</u> .		
2a) This action is <b>FINAL</b> . 2b)⊠ This	s action is non-final.		
3) Since this application is in condition for allowa	nce except for formal matters, pr	osecution as to the mer	its is
closed in accordance with the practice under	Ex parte Quayle, 1935 C.D. 11, 4	53 O.G. 213.	
Disposition of Claims			
4)⊠ Claim(s) <u>1-53</u> is/are pending in the application		·	
4a) Of the above claim(s) <u>51 and 52</u> is/are with			
5) Claim(s) is/are allowed.	•		
6)⊠ Claim(s) <u>1-50 and 53</u> is/are rejected.			- ·
7) Claim(s) is/are objected to.			
8) Claim(s) are subject to restriction and/o	or election requirement.		
Application Papers			
9) The specification is objected to by the Examine 10) The drawing(s) filed on <u>03 December 2001</u> is/a		tod to by the Eveminer	
Applicant may not request that any objection to the		•	
Replacement drawing sheet(s) including the correct			121(d).
11)☐ The oath or declaration is objected to by the E	•	•	` '
•			
Priority under 35 U.S.C. § 119			
12) Acknowledgment is made of a claim for foreigr	n priority under 35 U.S.C. § 119(a	ı)-(d) or (f).	
a) All b) Some * c) None of:			
<ul><li>1. Certified copies of the priority document</li><li>2. Certified copies of the priority document</li></ul>		tion No	
3. Copies of the certified copies of the prior	• •		í A
application from the International Burea	•	od iii ano riadonai olagi	· ·
* See the attached detailed Office action for a list		ed.	
	•		
Attachment(s)			
1) Notice of References Cited (PTO-892)	4) Interview Summary		
<ul> <li>2) Notice of Draftsperson's Patent Drawing Review (PTO-948)</li> <li>3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)</li> </ul>	Paper No(s)/Mail D 5) Notice of Informal F	Patent Application (PTO-152)	)
Paper No(s)/Mail Date <u>2/12/02;4/01/03</u> .	6) Other:	,	
LS Patent and Trademark Office			

**Art Unit: 1765** 

## **DETAILED ACTION**

## Election/Restrictions

1. Claims 51 and 52 are withdrawn from further consideration pursuant to 37 CFR 1.142(b) as being drawn to a nonelected Group II, there being no allowable generic or linking claim. Election was made **without** traverse in Paper No. 12053.

## **Double Patenting**

2. The nonstatutory double patenting rejection is based on a judicially created doctrine grounded in public policy (a policy reflected in the statute) so as to prevent the unjustified or improper timewise extension of the "right to exclude" granted by a patent and to prevent possible harassment by multiple assignees. See *In re Goodman*, 11 F.3d 1046, 29 USPQ2d 2010 (Fed. Cir. 1993); *In re Longi*, 759 F.2d 887, 225 USPQ 645 (Fed. Cir. 1985); *In re Van Ornum*, 686 F.2d 937, 214 USPQ 761 (CCPA 1982); *In re Vogel*, 422 F.2d 438, 164 USPQ 619 (CCPA 1970);and, *In re Thorington*, 418 F.2d 528, 163 USPQ 644 (CCPA 1969).

A timely filed terminal disclaimer in compliance with 37 CFR 1.321(c) may be used to overcome an actual or provisional rejection based on a nonstatutory double patenting ground provided the conflicting application or patent is shown to be commonly owned with this application. See 37 CFR 1.130(b).

Effective January 1, 1994, a registered attorney or agent of record may sign a terminal disclaimer. A terminal disclaimer signed by the assignee must fully comply with 37 CFR 3.73(b).

3. Claims 1-50, 53 are rejected under the judicially created doctrine of obviousness-type double patenting as being unpatentable over claims 1-21, 29-30 of U.S. Patent No. 5,795,381 in view of Wolf et al., Silicon Processing for the VLSI Era, Volume 1: Process Technology, Lattice Press, Sunset Beach ,CA, USA, pp. 1-108, 1986.

Art Unit: 1765

Claims 1-21, 29-30 disclose a method for transferring a sample of the gaseous environment from a growth chamber in which a single crystal Si ingot was being grown to a detector, analyzing the sample to determine the concentration of a contaminant in the atmosphere, using the concentration to determine and control at least one process parameter based on the contaminant gas concentration.

The claims do not require the pressure in the apparatus to be sub-atmospheric.

Wolf et al. discloses on page 18 the need to keep reactive gases out of the pulling chamber and the use of an inert purge gas flow to sweep such gases from the growth chamber. The growth chamber is sealed as shown in page 17. Growth at a reduced pressure (i.e. one that is sub-atmospheric) was known to reduce oxygen content in the ingot. Wolf et al. also suggests limiting the incorporation of atmospheric gases into the melt during growth by pumping out the chamber and backfilling with an inert gas in a purge as an ordinary step in the ingot pulling method (page 9). Page 101-105 detail the use of residual gas analyzers (RGA's). RGA's are mass analyzers useable at high vacuum (page 101). Common gases suggested as analyzed by Wolf et al. in pulling environments include N and CO (page 103), as well as H<sub>2</sub>O on page 104.

In respect to claims 1-2 and 53, it would have been obvious to one of ordinary skill in the art at the time of the present invention to combine the sub-atmospheric pressure of Wolf et al. with the method of the patent since the patented claims include control of oxygen content in the ingot grown.

Art Unit: 1765

In respect to claims 1 and 53, it would have been obvious to one of ordinary skill in the art at the time of the present invention to perform the patented claim at subatmospheric pressure because this would allow for oxygen content to be controlled in the product ingot as per the claims.

In respect to claim 2, it would have been obvious to one of ordinary skill in the art at the time of the present invention to analyze for the contaminant gas of CO or nitrogenor water vapor because Wolf et al. discloses these as common gases to analyze for in pulling system atmospheres.

In respect to claims 3-50, it would have been obvious to one of ordinary skill in the art at the time of the present invention to perform gas atmosphere analysis in a pulling apparatus by RGA because such was suggested by Wolf et al.

In respect to claims 3, 9, 10, 14, 15, 19, 20, 29, 30, 31, 40-42, 46-50, it would have been obvious to one of ordinary skill in the art at the time of the present invention to optimize the result effective variables of scan time (interval between analysis) because such near real time was achieved in the patent and such analysis would allow quick responsive control and process monitoring.

In respect to claims 4, 32, 43 it would have been obvious to one of ordinary skill in the art at the time of the present invention to use a RGA mass analyzer for the analysis in the patented claims because Wolf et al. suggests the RGA as effective in such ingot pulling systems.

In respect to claims 5-6, 33-34, 44-45, it would have been obvious to one of ordinary skill in the art at the time of the present invention to optimize the carbon

Art Unit: 1765

concentration and diameter of the pulled ingot since the claimed values were known to Wolf et al. to be result effective parameters.

In respect to claims 7, 12, 17, 22-23, 35, it would have been obvious to one of ordinary skill in the art at the time of the present invention to analyze the chamber for leaks prior to forming the molten mass for pulling in the chamber and to analyze the exhaust gases because this would allow for quality control processes by establishing a baseline atmosphere as well as ensuring contaminants were being pulled from the system.

In respect to claims 8, 13, 18, 25-28, 36-39, it would have been obvious to one of ordinary skill in the art at the time of the present invention to optimize the result effective parameter of gas concentration because the patent suggests gas analysis and control from that analysis and Wolf et al. suggests analysis for the specific atmospheric gases.

In respect to claims 11, 16, 21, 24, it would have been obvious to one of ordinary skill in the art at the time of the present invention to collect a sample from above or adjacent to the melt surface because this is suggested in the patented claims.

In respect to claims 12, it would have been obvious to one of ordinary skill in the art at the time of the present invention to analyze a sample of the exhaust gas from the chamber because

**Art Unit: 1765** 

## Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Matthew A. Anderson whose telephone number is (571) 272-1459. The examiner can normally be reached on M-Th, 7-5:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nadine Norton can be reached on (571) 272-1465. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

MAA February 11, 2004

NADINE G. NORTON
SUPERVISORY PATENT EXAMINER